## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

Hirohito OKUDA et al.

Serial No.:

10/809,464

Filed:

March 26, 2004

Title:

APPARATUS AND METHOD FOR CLASSIFYING DEFECTS USING MULTIPLE CLASSIFICATION MODULES (as amended)

Group:

2624

Examiner:

**Edward PARK** 

Confirmation No.:

7643

## <u>AMENDMENT</u>

Mail Stop: AF

Commissioner for Patents

P.O. Box 1450

Alexandria, Virginia 22313-1450

May 14, 2009

Sir:

In response to the Office Action dated January 14, 2009, the period of response for which extension of time is requested in the attached Petition for Extension of Time, and filed concurrently with the attached Request for Continued Examination (RCE), please amend the above-identified application as listed below and as set forth on the following pages:

Amendments to the claims begin on page 2;

Remarks are included beginning on page 6; and

Authorization is included on page 12.